

**Table 1: General Features**

TYPE	V <sub>CE(S)</sub>	V <sub>CE(sat)</sub> (Max) @25°C	I <sub>C</sub> @100°C
STGF7NB60SL	600 V	< 1.6 V	7 A

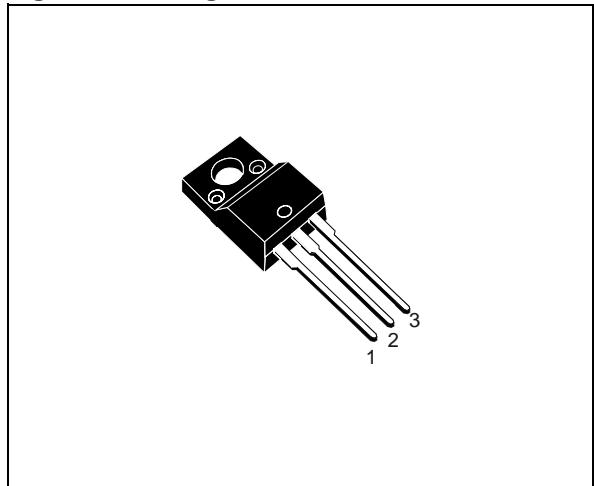
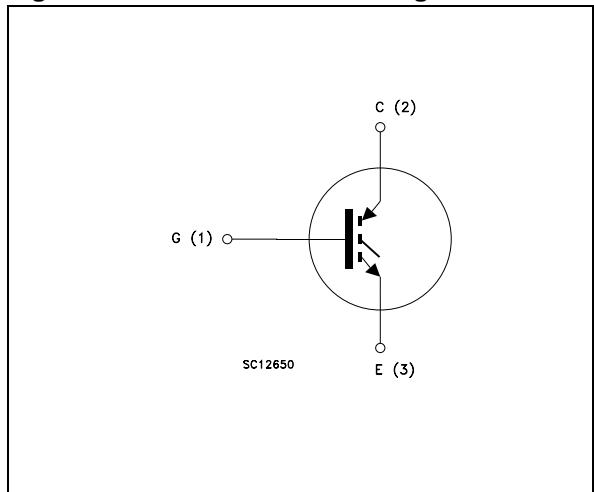
- POLYSILICON GATE VOLTAGE DRIVEN
- LOW THRESHOLD VOLTAGE
- LOW ON-VOLTAGE DROP
- LOW GATE CHARGE
- HIGH CURRENT CAPABILITY

### DESCRIPTION

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "S" identifies a family optimized achieve minimum on-voltage drop for low frequency applications (<1kHz).

### APPLICATIONS

- LIGHT DIMMER
- STATIC RELAYS

**Figure 1: Package**

**Figure 2: Internal Schematic Diagram**

**Table 2: Order Codes**

SALES TYPE	MARKING	PACKAGE	PACKAGING
STGF7NB60SL	GF7NB60SL	TO-220FP	TUBE

**Table 3: Absolute Maximum ratings**

Symbol	Parameter	Value	Symbol
$V_{CES}$	Collector-Emitter Voltage ( $V_{GS} = 0$ )	600	V
$V_{ECR}$	Reverse Battery Protection	20	V
$V_{GE}$	Gate-Emitter Voltage	$\pm 20$	V
$I_C$	Collector Current (continuous) at $25^\circ\text{C}$	15	A
$I_C$	Collector Current (continuous) at $100^\circ\text{C}$	7	A
$I_{CM}$ (1)	Collector Current (pulsed)	20	A
$P_{TOT}$	Total Dissipation at $T_C = 25^\circ\text{C}$	25	W
	Derating Factor	0.2	W/ $^\circ\text{C}$
$V_{ISO}$	Insulation Withstand Voltage A.C.	2500	V
$T_{stg}$	Storage Temperature	– 55 to 150	$^\circ\text{C}$
$T_j$	Operating Junction Temperature		

(1)Pulse width limited by max. junction temperature.

**Table 4: Thermal Data**

Rthj-case	Thermal Resistance Junction-case Max	5	$^\circ\text{C}/\text{W}$
Rthj-amb	Thermal Resistance Junction-ambient Max	62.5	$^\circ\text{C}/\text{W}$

**ELECTRICAL CHARACTERISTICS (T<sub>CASE</sub> =25°C UNLESS OTHERWISE SPECIFIED)****Table 5: Off**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{BR(CES)}$	Collectro-Emitter Breakdown Voltage	$I_C = 250 \mu\text{A}, V_{GE} = 0$	600			V
$V_{BR(ECS)}$	Emitter-Collector Breakdown Voltage	$I_C = 1\text{mA}, V_{GE} = 0$	20			V
$I_{CES}$	Collector-Emitter Leakage Current ( $V_{CE} = 0$ )	$V_{GE} = \text{Max Rating}$ $T_c=25^\circ\text{C}$ $T_c=125^\circ\text{C}$			10 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GES}$	Gate-Emitter Leakage Current ( $V_{CE} = 0$ )	$V_{GE} = \pm 20 \text{ V}, V_{CE} = 0$			$\pm 100$	nA

**Table 6: On**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GE(th)}$	Gate Threshold Voltage	$V_{CE}=V_{GE}, I_C= 250 \mu\text{A}$	1.2		2.4	V
$V_{CE(SAT)}$	Collector-Emitter Saturation Voltage	$V_{GE}=4.5 \text{ V}, I_C= 7\text{A}, T_j= 25^\circ\text{C}$ $V_{GE}=4.5 \text{ V}, I_C= 7\text{A}, T_j= 125^\circ\text{C}$		1.2 1.1	1.6	V V

**ELECTRICAL CHARACTERISTICS (CONTINUED)****Table 7: Dynamic**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$g_{fs}$	Forward Transconductance	$V_{CE} = 15 \text{ V}, I_C = 7 \text{ A}$		5		S
$C_{ies}$ $C_{oes}$ $C_{res}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GE} = 0$		800 60 10		pF pF pF
$Q_g$ $Q_{ge}$ $Q_{gc}$	Total Gate Charge Gate-Emitter Charge Gate-Collector Charge	$V_{CE} = 480 \text{ V}, I_C = 7 \text{ A},$ $V_{GE} = 5 \text{ V}$ (see Figure 20)		16 2.5 8.5	22	nC nC nC
$I_{CL}$	Turn-Off SOA Minimum Current	$V_{clamp} = 480 \text{ V}, T_j = 125^\circ\text{C}$ $R_G = 1 \text{ k}\Omega, V_{GE}=5\text{V}$	20			A
tscw	Short Circuit Withstand Time	$V_{ce} = 0.5 \text{ V}_{BR(CES)}, V_{GE}=5\text{V},$ $T_j = 125^\circ\text{C}, R_G = 1\text{k}\Omega$		14		$\mu\text{s}$

**Table 8: Switching On**

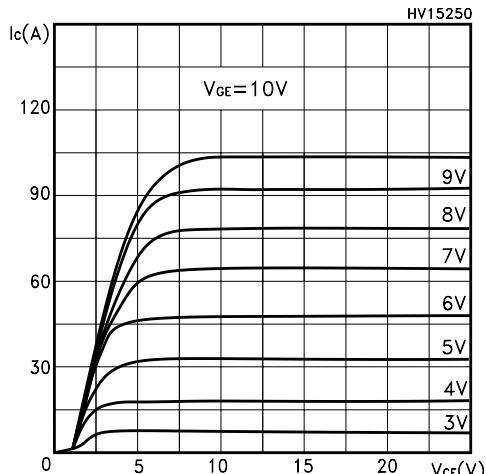
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on Delay Time Current Rise Time	$V_{CC} = 480 \text{ V}, I_C = 7 \text{ A } R_G=1\text{k}\Omega,$ $V_{GE} = 5 \text{ V}$ (see Figure 18)		1.1 0.25		$\mu\text{s}$ $\mu\text{s}$
$(di/dt)_{on}$ $E_{on}$	Turn-on Current Slope Turn-on Switching Losses	$V_{CC} = 480 \text{ V}, I_C = 7 \text{ A } R_G=1\text{k}\Omega$ $V_{GE} = 5 \text{ V}, T_j = 125^\circ\text{C}$		45 2.7		$\text{A}/\mu\text{s}$ $\text{mJ}$

**Table 9: Switching Off**

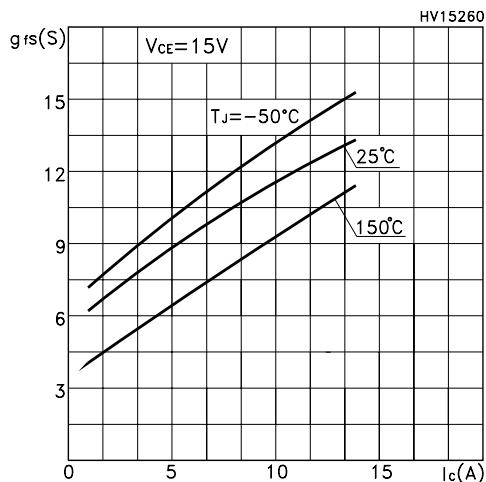
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_c$ $t_r(V_{off})$	Cross-over Time Off Voltage Rise Time	$V_{cc} = 480 \text{ V}, I_C = 7 \text{ A},$ $R_{GE} = 1\text{k}\Omega, V_{GE} = 5 \text{ V}$ (see Figure 18)		2.7 1.6		$\mu\text{s}$ $\mu\text{s}$
$t_d(off)$ $t_f$	Delay Time Current Fall Time			5.2 1.1		$\mu\text{s}$ $\mu\text{s}$
$E_{off}^{(**)}$	Turn-off Switching Loss			4.1		mJ
$t_c$ $t_r(V_{off})$	Cross-over Time Off Voltage Rise Time	$V_{cc} = 480 \text{ V}, I_C = 7 \text{ A},$ $R_{GE} = 1\text{k}\Omega, V_{GE} = 5 \text{ V}$ $T_j = 125^\circ\text{C}$ (see Figure 18)		4.4 2.4		$\mu\text{s}$ $\mu\text{s}$
$t_d(off)$ $t_f$	Delay Time Fall Time			6.4 1.7		$\mu\text{s}$ $\mu\text{s}$
$E_{off}^{(**)}$	Turn-off Switching Loss			7.1		mJ

(\*\*) Turn-off losses include also the tail of the collector current.

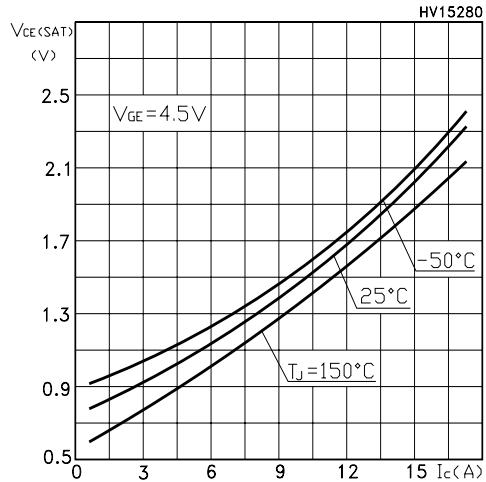
**Figure 3: Output Characteristics**



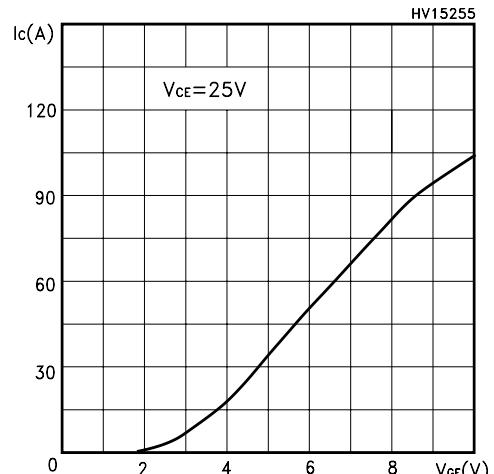
**Figure 4: Transconductance**



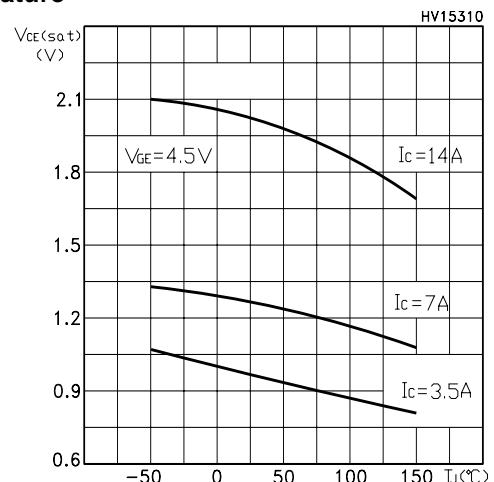
**Figure 5: Collector-Emitter On Voltage vs Collector Current**



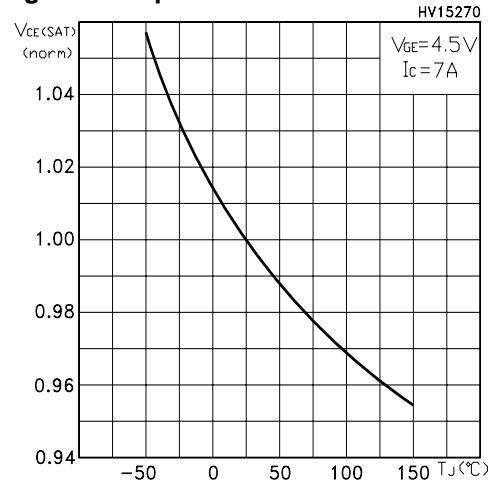
**Figure 6: Transfer Characteristics**

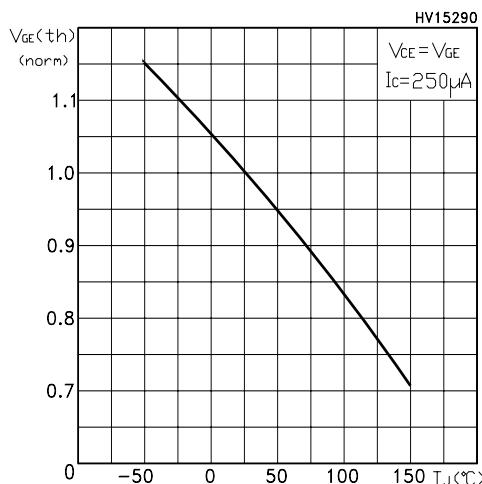
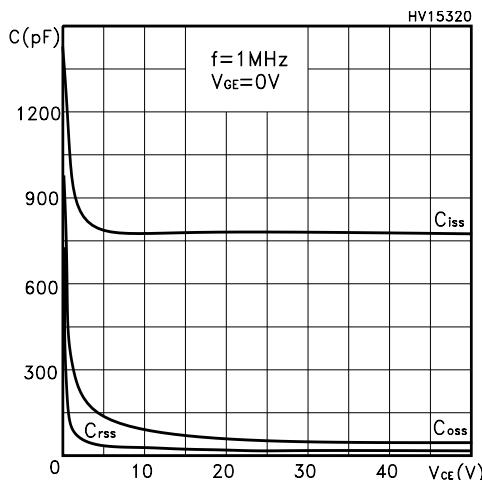
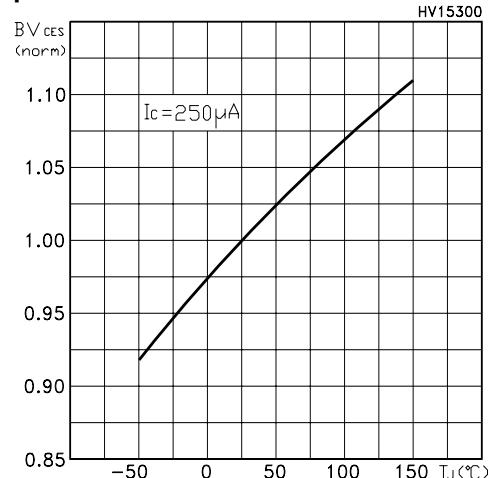
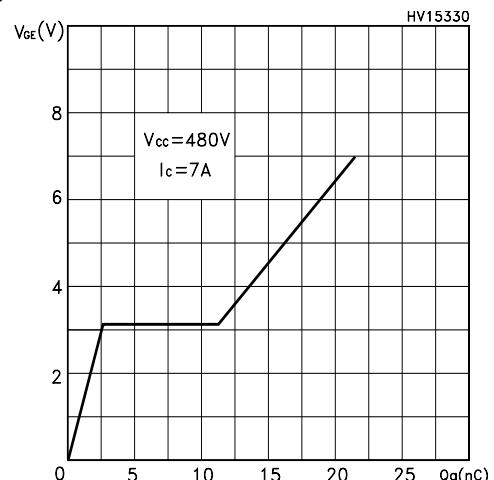
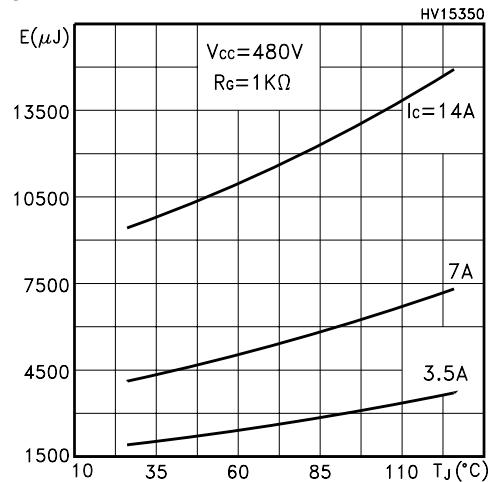


**Figure 7: Collector-Emitter On Voltage vs Temperature**

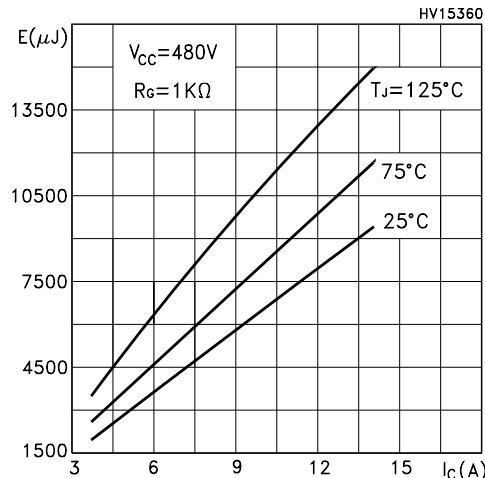


**Figure 8: Normalized Collector-Emitter On Voltage vs Temperature**

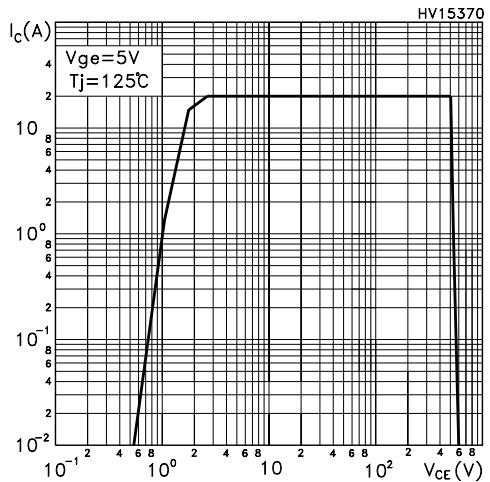


**Figure 9: Gate Threshold vs Temperature****Figure 10: Capacitance Variations****Figure 11: Total Switching Losses vs Gate Resistance****Figure 12: Normalized Breakdown Voltage vs Temperature****Figure 13: Gate Charge vs Gate-Emitter Voltage****Figure 14: Total Switching Losses vs Temperature**

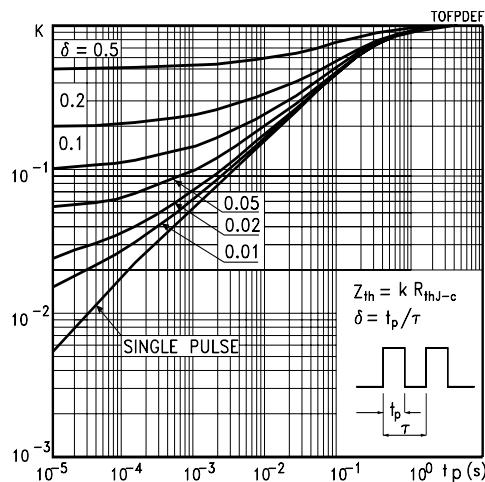
**Figure 15: Total Switching Losses vs Collector Current**



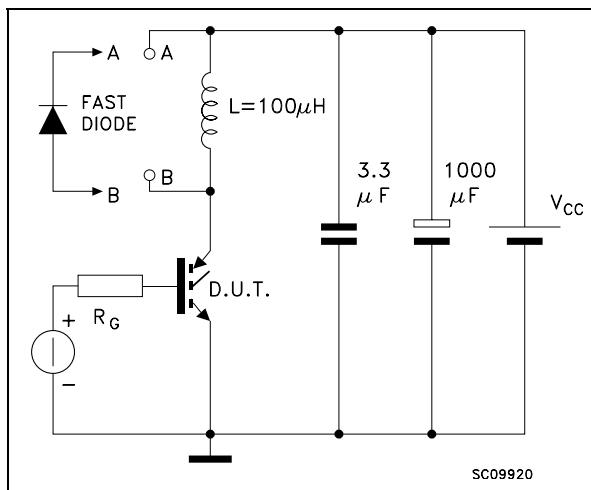
**Figure 17: Turn-Off SOA**



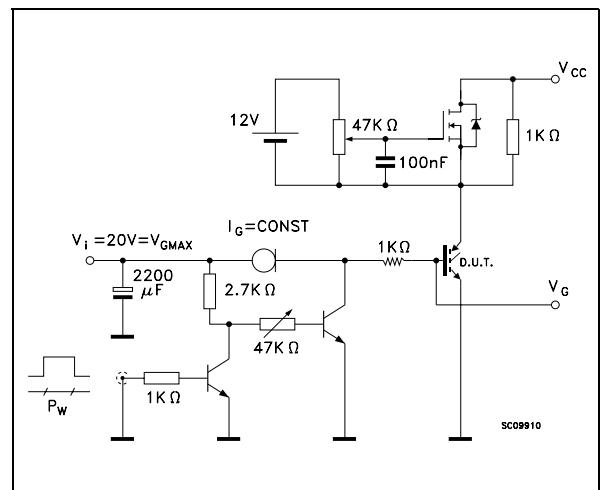
**Figure 16: Thermal Impedance**



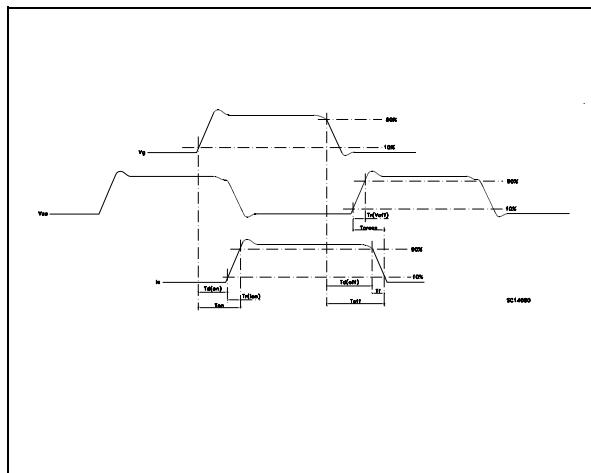
**Figure 18: Test Circuit for Inductive Load Switching**



**Figure 20: Gate Charge Test Circuit**



**Figure 19: Switching Waveforms**



**Table 10: Revision History**

Date	Revision	Description of Changes
04-June-2004	2	Stylesheet update. No content change
02-Sep-2004	3	Datasheet updated, see table1